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Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	STM8
Core Size	8-Bit
Speed	16MHz
Connectivity	I ² C, IrDA, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, IR, LCD, POR, PWM, WDT
Number of I/O	54
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 28x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm8l152r8t3

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2.2 Device overview

Table 2. High-density and medium+ density STM8L15xx6/8 low power device features and peripheral counts

Features		STM8L15xC8	STM8L15xK8	STM8L15xR8	STM8L15xM8	STM8L15xR6
Flash (Kbyte)		64	64	64	64	32
Data EEPROM (Kbyte)		2	2	2	2	1
RAM (Kbyte)		4	4	4	4	2
LCD		8x24 or 4x28 ⁽¹⁾	4x15 ⁽¹⁾	8x36 or 4x40 ⁽¹⁾	8x40 or 4x44 ⁽¹⁾	8x36 or 4x40 ⁽¹⁾
Timers	Basic	1 (8-bit)	1 (8-bit)	1 (8-bit)	1 (8-bit)	1 (8-bit)
	General purpose	3 (16-bit)	3 (16-bit)	3 (16-bit)	3 (16-bit)	3 (16-bit)
	Advanced control	1 (16-bit)	1 (16-bit)	1 (16-bit)	1 (16-bit)	1 (16-bit)
Communication interfaces	SPI	2	1	2	2	2
	I2C	1	1	1	1	1
	USART	3	2	3	3	3
GPIOs		41 ⁽²⁾	28 ⁽²⁾	54 ⁽²⁾	68 ⁽²⁾	54 ⁽²⁾
12-bit synchronized ADC (number of channels)		1 (25)	1 (18)	1 (28)	1 (28)	1 (28)
12-Bit DAC		2	1	2	2	2
Number of channels		2	1	2	2	2
Comparators (COMP1/COMP2)		2	2	2	2	2
Others		RTC, window watchdog, independent watchdog, 16-MHz and 38-kHz internal RC, 1- to 16-MHz and 32-kHz external oscillator				
CPU frequency		16 MHz				
Operating voltage		1.8 to 3.6 V (down to 1.65 V at power-down) with BOR 1.65 to 3.6 V without BOR				
Operating temperature		−40 to +85 °C / −40 to +105 °C / −40 to +125 °C				
Packages		UFQFPN48 LQFP48	WLCSP32	LQFP64	LQFP80	LQFP64

1. STM8L152x6/8 versions only.

2. The number of GPIOs given in this table includes the NRST/PA1 pin but the application can use the NRST/PA1 pin as general purpose output only (PA1).

3.2 Central processing unit STM8

3.2.1 Advanced STM8 Core

The 8-bit STM8 core is designed for code efficiency and performance with an Harvard architecture and a 3-stage pipeline.

It contains 6 internal registers which are directly addressable in each execution context, 20 addressing modes including indexed indirect and relative addressing, and 80 instructions.

Architecture and registers

- Harvard architecture
- 3-stage pipeline
- 32-bit wide program memory bus - single cycle fetching most instructions
- X and Y 16-bit index registers - enabling indexed addressing modes with or without offset and read-modify-write type data manipulations
- 8-bit accumulator
- 24-bit program counter - 16 Mbyte linear memory space
- 16-bit stack pointer - access to a 64 Kbyte level stack
- 8-bit condition code register - 7 condition flags for the result of the last instruction

Addressing

- 20 addressing modes
- Indexed indirect addressing mode for lookup tables located anywhere in the address space
- Stack pointer relative addressing mode for local variables and parameter passing

Instruction set

- 80 instructions with 2-byte average instruction size
- Standard data movement and logic/arithmetic functions
- 8-bit by 8-bit multiplication
- 16-bit by 8-bit and 16-bit by 16-bit division
- Bit manipulation
- Data transfer between stack and accumulator (push/pop) with direct stack access
- Data transfer using the X and Y registers or direct memory-to-memory transfers

3.2.2 Interrupt controller

The high-density and medium+ density STM8L15xx6/8x devices feature a nested vectored interrupt controller:

- Nested interrupts with 3 software priority levels
- 32 interrupt vectors with hardware priority
- Up to 40 external interrupt sources on 11 vectors
- Trap and reset interrupts

Table 5. High-density and medium+ density STM8L15x pin description (continued)

Pin number				Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP80	LQFP64	UFQFPN48 and LQFP48	WLCSP32				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
48	-	-	-	V _{SS4}	S	-	-	-	-	-	-	-	IOs ground voltage	
47	-	-	-	V _{DD4}	S	-	-	-	-	-	-	-	IOs supply voltage	

- At power-up, the PA1/NRST pin is a reset input pin with pull-up. To be used as a general purpose pin (PA1), it can be configured only as output push-pull, not as output open-drain nor as a general purpose input. Refer to Section *Configuring NRST/PA1 pin as general purpose output* in the STM8L15xxx and STM8L16xxx reference manual (RM0031).
- [] Alternate function remapping option (if the same alternate function is shown twice, it indicates an exclusive choice not a duplication of the function).
- Available on STM8L152x6/8 devices only.
- Even if this I/O is not available on the device pin, it is considered as active and must be configured to input pull up or output mode by software to avoid spurious behavior and increased consumption.
- A pull-up is applied to PB0 and PB4 during the reset phase. These two pins are input floating after reset release.
- In the 5 V tolerant I/Os, the protection diode to V_{DD} is not implemented.
- In the open-drain output column, 'T' defines a true open-drain I/O (P-buffer, weak pull-up and protection diode to V_{DD} are not implemented).
- Available on STM8L152xx devices only. On STM8L151xx devices it is reserved and must be tied to V_{DD}.
- The PA0 pin is in input pull-up during the reset phase and after reset release.
- High Sink LED driver capability available on PA0.

Note: Slope control of all GPIO pins can be programmed except true open drain pins and by default is limited to 2 MHz.

System configuration options

As shown in [Table 5: High-density and medium+ density STM8L15x pin description](#), some alternate functions can be remapped on different I/O ports by programming one of the two remapping registers described in the “Routing interface (RI) and system configuration controller” section in the STM8L05xxx, STM8L15xxx and STM8L16xxx reference manual (RM0031).

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5084	Reserved area (1 byte)			
0x00 5085	DMA1	DMA1_C1M0ARH	DMA1 memory 0 address high register (channel 1)	0x00
0x00 5086		DMA1_C1M0ARL	DMA1 memory 0 address low register (channel 1)	0x00
0x00 5087 0x00 5088	Reserved area (2 byte)			
0x00 5089	DMA1	DMA1_C2CR	DMA1 channel 2 configuration register	0x00
0x00 508A		DMA1_C2SPR	DMA1 channel 2 status & priority register	0x00
0x00 508B		DMA1_C2NDTR	DMA1 number of data to transfer register (channel 2)	0x00
0x00 508C		DMA1_C2PARH	DMA1 peripheral address high register (channel 2)	0x52
0x00 508D		DMA1_C2PARL	DMA1 peripheral address low register (channel 2)	0x00
0x00 508E		Reserved area (1 byte)		
0x00 508F		DMA1_C2M0ARH	DMA1 memory 0 address high register (channel 2)	0x00
0x00 5090		DMA1_C2M0ARL	DMA1 memory 0 address low register (channel 2)	0x00
0x00 5091 0x00 5092	Reserved area (2 byte)			
0x00 5093	DMA1	DMA1_C3CR	DMA1 channel 3 configuration register	0x00
0x00 5094		DMA1_C3SPR	DMA1 channel 3 status & priority register	0x00
0x00 5095		DMA1_C3NDTR	DMA1 number of data to transfer register (channel 3)	0x00
0x00 5096		DMA1_C3PARH_ C3M1ARH	DMA1 peripheral address high register (channel 3)	0x40
0x00 5097		DMA1_C3PARL_ C3M1ARL	DMA1 peripheral address low register (channel 3)	0x00
0x00 5098		DMA_C3M0EAR	DMA channel 3 memory 0 extended address register	0x00
0x00 5099		DMA1_C3M0ARH	DMA1 memory 0 address high register (channel 3)	0x00
0x00 509A		DMA1_C3M0ARL	DMA1 memory 0 address low register (channel 3)	0x00
0x00 509B to 0x00 509C	Reserved area (3 byte)			

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 53C8 to 0x00 53DF	Reserved area			
0x00 53E0	USART2	USART2_SR	USART2 status register	0xC0
0x00 53E1		USART2_DR	USART2 data register	0xFF
0x00 53E2		USART2_BRR1	USART2 baud rate register 1	0x00
0x00 53E3		USART2_BRR2	USART2 baud rate register 2	0x00
0x00 53E4		USART2_CR1	USART2 control register 1	0x00
0x00 53E5		USART2_CR2	USART2 control register 2	0x00
0x00 53E6		USART2_CR3	USART2 control register 3	0x00
0x00 53E7		USART2_CR4	USART2 control register 4	0x00
0x00 53E8		USART2_CR5	USART2 control register 5	0x00
0x00 53E9		USART2_GTR	USART2 guard time register	0x00
0x00 53EA		USART2_PSCR	USART2 prescaler register	0x00
0x00 53EB to 0x00 53EF	Reserved area			
0x00 53F0	USART3	USART3_SR	USART3 status register	0xC0
0x00 53F1		USART3_DR	USART3 data register	0xFF
0x00 53F2		USART3_BRR1	USART3 baud rate register 1	0x00
0x00 53F3		USART3_BRR2	USART3 baud rate register 2	0x00
0x00 53F4		USART3_CR1	USART3 control register 1	0x00
0x00 53F5		USART3_CR2	USART3 control register 2	0x00
0x00 53F6		USART3_CR3	USART3 control register 3	0x00
0x00 53F7		USART3_CR4	USART3 control register 4	0x00
0x00 53F8		USART3_CR5	USART3 control register 5	0x00
0x00 53F9		USART3_GTR	USART3 guard time register	0x00
0x00 53FA		USART3_PSCR	USART3 prescaler register	0x00
0x00 53FB to 0x00 53FF	Reserved area			

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5400	LCD	LCD_CR1	LCD control register 1	0x00
0x00 5401		LCD_CR2	LCD control register 2	0x00
0x00 5402		LCD_CR3	LCD control register 3	0x00
0x00 5403		LCD_FRQ	LCD frequency selection register	0x00
0x00 5404		LCD_PM0	LCD Port mask register 0	0x00
0x00 5405		LCD_PM1	LCD Port mask register 1	0x00
0x00 5406		LCD_PM2	LCD Port mask register 2	0x00
0x00 5407		LCD_PM3	LCD Port mask register 3	0x00
0x00 5408		LCD_PM4	LCD Port mask register 4	0x00
0x00 5409		LCD_PM5	LCD Port mask register 5	0x00
0x00 540A to 0x00 540B	Reserved area (2 byte)			
0x00 540C	LCD	LCD_RAM0	LCD display memory 0	0x00
0x00 540D		LCD_RAM1	LCD display memory 1	0x00
0x00 540E		LCD_RAM2	LCD display memory 2	0x00
0x00 540F		LCD_RAM3	LCD display memory 3	0x00
0x00 5410		LCD_RAM4	LCD display memory 4	0x00
0x00 5411		LCD_RAM5	LCD display memory 5	0x00
0x00 5412		LCD_RAM6	LCD display memory 6	0x00
0x00 5413		LCD_RAM7	LCD display memory 7	0x00
0x00 5414		LCD_RAM8	LCD display memory 8	0x00
0x00 5415		LCD_RAM9	LCD display memory 9	0x00
0x00 5416		LCD_RAM10	LCD display memory 10	0x00
0x00 5417		LCD_RAM11	LCD display memory 11	0x00
0x00 5418		LCD_RAM12	LCD display memory 12	0x00
0x00 5419		LCD_RAM13	LCD display memory 13	0x00
0x00 541A		LCD_RAM14	LCD display memory 14	0x00
0x00 541B		LCD_RAM15	LCD display memory 15	0x00
0x00 541C		LCD_RAM16	LCD display memory 16	0x00
0x00 541D		LCD_RAM17	LCD display memory 17	0x00
0x00 541E		LCD_RAM18	LCD display memory 18	0x00
0x00 541F		LCD_RAM19	LCD display memory 19	0x00
0x00 5420		LCD_RAM20	LCD display memory 20	0x00
0x00 5421	LCD	LCD_RAM21	LCD display memory 21	0x00

6 Interrupt vector mapping

Table 11. Interrupt mapping

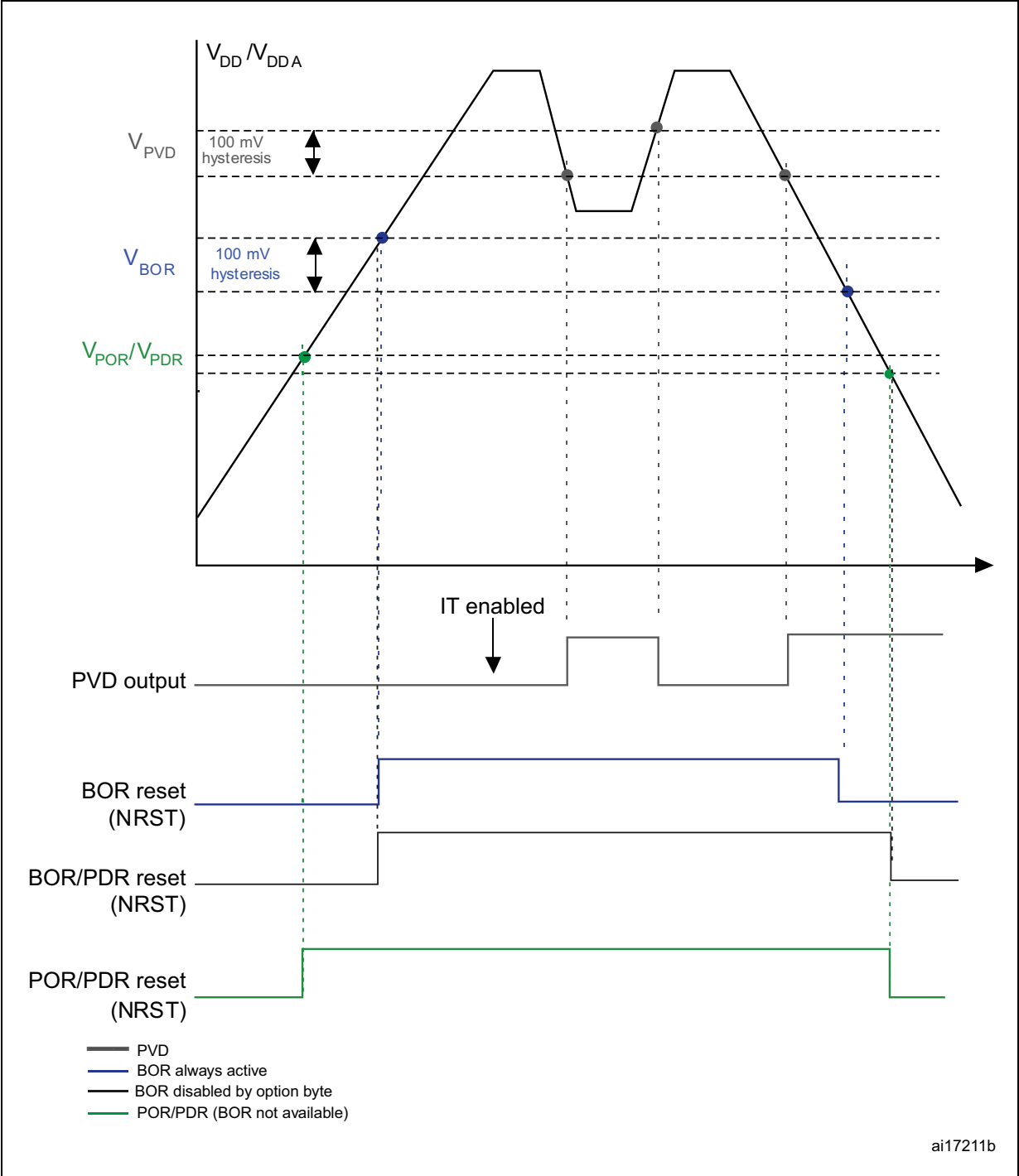
IRQ No.	Source block	Description	Wakeup from Halt mode	Wakeup from Active-halt mode	Wakeup from Wait (WFI mode)	Wakeup from Wait (WFE mode) ⁽¹⁾	Vector address
-	RESET	Reset	Yes	Yes	Yes	Yes	0x00 8000
-	TRAP	Software interrupt	-	-	-	-	0x00 8004
0	TLI ⁽²⁾	External Top level Interrupt	-	-	-	-	0x00 8008
1	FLASH	EOP/WR_PG_DIS	-	-	Yes	Yes ⁽³⁾	0x00 800C
2	DMA1 0/1	DMA1 channels 0/1	-	-	Yes	Yes ⁽³⁾	0x00 8010
3	DMA1 2/3	DMA1 channels 2/3	-	-	Yes	Yes ⁽³⁾	0x00 8014
4	RTC/LSE_CSS	RTC alarm interrupt/LSE CSS interrupt	Yes	Yes	Yes	Yes	0x00 8018
5	EXTI E/F/PVD ⁽⁴⁾	PortE/F interrupt/PVD interrupt	Yes	Yes	Yes	Yes ⁽³⁾	0x00 801C
6	EXTIB/G	External interrupt port B/G	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8020
7	EXTID/H	External interrupt port D/H	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8024
8	EXTI0	External interrupt 0	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8028
9	EXTI1	External interrupt 1	Yes	Yes	Yes	Yes ⁽³⁾	0x00 802C
10	EXTI2	External interrupt 2	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8030
11	EXTI3	External interrupt 3	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8034
12	EXTI4	External interrupt 4	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8038
13	EXTI5	External interrupt 5	Yes	Yes	Yes	Yes ⁽³⁾	0x00 803C
14	EXTI6	External interrupt 6	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8040
15	EXTI7	External interrupt 7	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8044
16	LCD	LCD interrupt	-	-	Yes	Yes	0x00 8048
17	CLK/TIM1/DAC	System clock switch/CSS interrupt/TIM1 break/DAC	-	-	Yes	Yes	0x00 804C
18	COMP1/COMP2 ADC1	Comparator 1 and 2 interrupt/ADC1	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8050
19	TIM2/USART2	TIM2 update /overflow/trigger/break/ USART2 transmission complete/transmit data register empty interrupt	-	-	Yes	Yes ⁽³⁾	0x00 8054

9.3.2 Embedded reset and power control block characteristics

Table 19. Embedded reset and power control block characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t_{VDD}	V_{DD} rise time rate	BOR detector enabled	0 ⁽¹⁾	-	∞ ⁽¹⁾	$\mu\text{s/V}$
		BOR detector disabled	0 ⁽¹⁾	-	1 ⁽¹⁾	ms/V
	V_{DD} fall time rate	BOR detector enabled	20 ⁽¹⁾	-	∞ ⁽¹⁾	$\mu\text{s/V}$
		BOR detector disabled	Reset below voltage functional range			
t_{TEMP}	Reset release delay	V_{DD} rising BOR detector enabled	-	3	-	ms
		V_{DD} rising BOR detector disabled	-	1	-	
V_{POR}	Power-on reset threshold	Rising edge	1.3 ⁽²⁾	1.5	1.65	V
V_{PDR}	Power-down reset threshold	Falling edge	1.3 ⁽²⁾	1.5	1.65	
V_{BOR0}	Brown-out reset threshold 0 (BOR_TH[2:0]=000)	Falling edge	1.67	1.7	1.74	
		Rising edge	1.69	1.75	1.80	
V_{BOR1}	Brown-out reset threshold 1 (BOR_TH[2:0]=001)	Falling edge	1.87	1.93	1.97	
		Rising edge	1.96	2.04	2.07	
V_{BOR2}	Brown-out reset threshold 2 (BOR_TH[2:0]=010)	Falling edge	2.22	2.3	2.35	
		Rising edge	2.31	2.41	2.44	
V_{BOR3}	Brown-out reset threshold 3 (BOR_TH[2:0]=011)	Falling edge	2.45	2.55	2.60	
		Rising edge	2.54	2.66	2.7	
V_{BOR4}	Brown-out reset threshold 4 (BOR_TH[2:0]=100)	Falling edge	2.68	2.80	2.85	
		Rising edge	2.78	2.90	2.95	

Figure 13. Power supply thresholds



9.3.3 Supply current characteristics

Total current consumption

The MCU is placed under the following conditions:

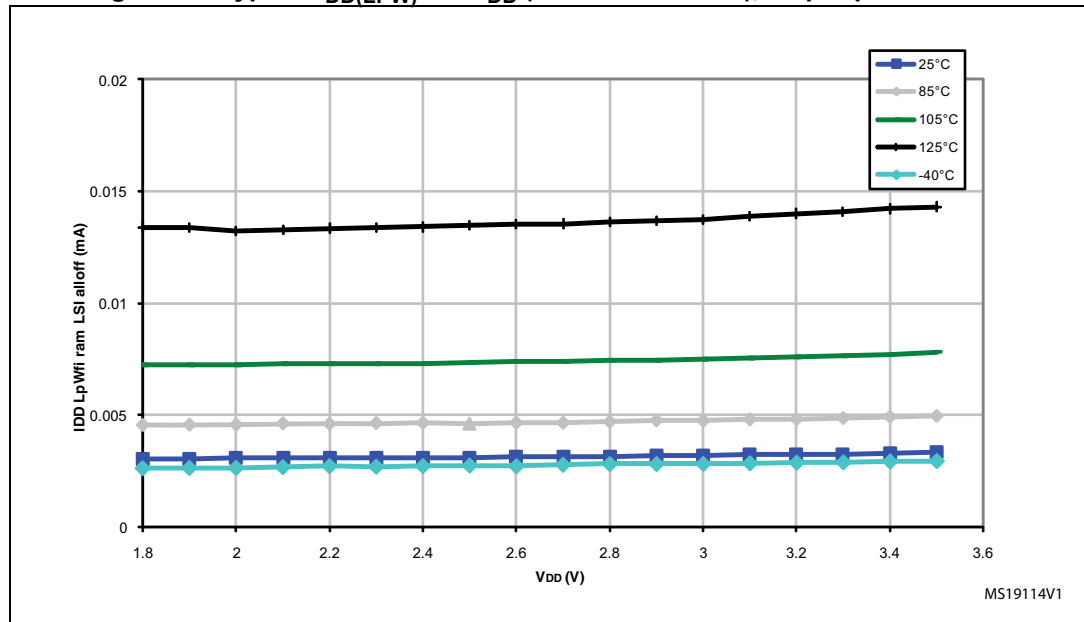
- All I/O pins in input mode with a static value at V_{DD} or V_{SS} (no load)
- All peripherals are disabled except if explicitly mentioned.

In the following table, data are based on characterization results, unless otherwise specified.

Subject to general operating conditions for V_{DD} and T_A .

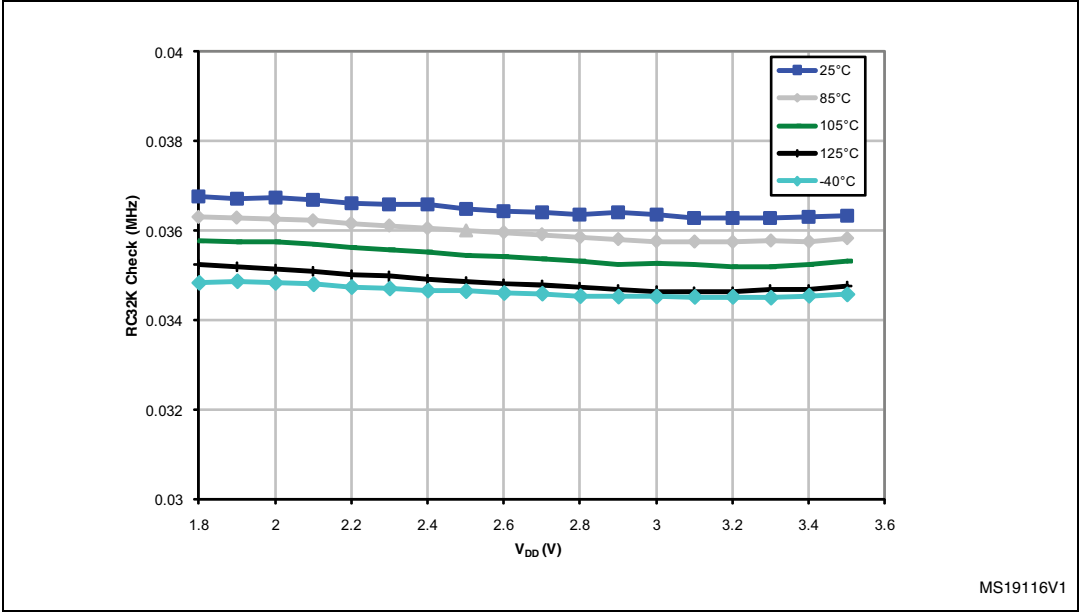
Table 20. Total current consumption in Run mode

Symbol	Parameter	Conditions ⁽¹⁾			Typ.	Max.				Unit
						55°C	85 °C (2)	105 °C (3)	125 °C (4)	
$I_{DD(RUN)}$	Supply current in run mode ⁽⁵⁾	All peripherals OFF, code executed from RAM, V_{DD} from 1.65 V to 3.6 V	HSI RC osc. (16 MHz) ⁽⁶⁾	$f_{CPU} = 125 \text{ kHz}$	0.22	0.28	0.39	0.47	0.51	mA
				$f_{CPU} = 1 \text{ MHz}$	0.32	0.38	0.49	0.57	0.61	
				$f_{CPU} = 4 \text{ MHz}$	0.59	0.65	0.76	0.84	0.88	
				$f_{CPU} = 8 \text{ MHz}$	0.93	0.99	1.1	1.18	1.22	
				$f_{CPU} = 16 \text{ MHz}$	1.62	1.68	1.79 ⁽⁷⁾	1.87 ⁽⁷⁾	1.91 ⁽⁷⁾	
			HSE external clock ($f_{CPU}=f_{HSE}$) ⁽⁸⁾	$f_{CPU} = 125 \text{ kHz}$	0.21	0.25	0.35	0.44	0.49	
				$f_{CPU} = 1 \text{ MHz}$	0.3	0.34	0.44	0.53	0.58	
				$f_{CPU} = 4 \text{ MHz}$	0.57	0.61	0.71	0.8	0.85	
				$f_{CPU} = 8 \text{ MHz}$	0.95	0.99	1.09	1.18	1.23	
				$f_{CPU} = 16 \text{ MHz}$	1.73	1.77	1.87 ⁽⁷⁾	1.96 ⁽⁷⁾	2.01 ⁽⁷⁾	
			LSI RC osc. (typ. 38 kHz)	$f_{CPU} = f_{LSI}$	0.029	0.035	0.039	0.044	0.055	
			LSE external clock (32.768 kHz)	$f_{CPU} = f_{LSE}$	0.028	0.034	0.038	0.042	0.054	

Figure 19. Typical $I_{DD(LPW)}$ vs. V_{DD} (LSI clock source), all peripherals OFF

1. Typical current consumption measured with code executed from RAM.

Figure 25. Typical LSI clock source frequency vs. V_{DD}



9.3.5 Memory characteristics

T_A = -40 to 125 °C unless otherwise specified.

Table 35. RAM and hardware registers

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{RM}	Data retention mode ⁽¹⁾	Halt mode (or Reset)	1.65	-	-	V

1. Minimum supply voltage without losing data stored in RAM (in Halt mode or under Reset) or in hardware registers (only in Halt mode). Guaranteed by characterization.

In the following table, data based on characterization results.

Table 51. DAC accuracy

Symbol	Parameter	Conditions	Typ.	Max.	Unit
DNL	Differential non linearity ⁽¹⁾	$R_L \geq 5 \text{ k}\Omega$, $C_L \leq 50 \text{ pF}$ DACOUT buffer ON ⁽²⁾	1.5	3	12-bit LSB
		No load DACOUT buffer OFF	1.5	3	
INL	Integral non linearity ⁽³⁾	$R_L \geq 5 \text{ k}\Omega$, $C_L \leq 50 \text{ pF}$ DACOUT buffer ON ⁽²⁾	2	4	
		No load DACOUT buffer OFF	2	4	
Offset	Offset error ⁽⁴⁾	$R_L \geq 5 \text{ k}\Omega$, $C_L \leq 50 \text{ pF}$ DACOUT buffer ON ⁽²⁾	± 10	± 25	
		No load DACOUT buffer OFF	± 5	± 8	
Offset1	Offset error at Code 1 ⁽⁵⁾	DACOUT buffer OFF	± 1.5	± 5	
Gain error	Gain error ⁽⁶⁾	$R_L \geq 5 \text{ k}\Omega$, $C_L \leq 50 \text{ pF}$ DACOUT buffer ON ⁽²⁾	+0.1/-0.2	+0.2/-0.5	%
		No load DACOUT buffer OFF	+0/-0.2	+0/-0.4	
TUE	Total unadjusted error	$R_L \geq 5 \text{ k}\Omega$, $C_L \leq 50 \text{ pF}$ DACOUT buffer ON ⁽²⁾	12	30	12-bit LSB
		No load -DACOUT buffer OFF	8	12	

1. Difference between two consecutive codes - 1 LSB.
2. In 48-pin package devices the DAC2 output buffer must be kept off and no load must be applied on the DAC_OUT2 output.
3. Difference between measured value at Code i and the value at Code i on a line drawn between Code 0 and last Code 1023.
4. Difference between the value measured at Code (0x800) and the ideal value = $V_{REF}/2$.
5. Difference between the value measured at Code (0x001) and the ideal value.
6. Difference between the ideal slope of the transfer function and the measured slope computed from Code 0x000 and 0xFFFF when buffer is ON, and from Code giving 0.2 V and ($V_{DDA} - 0.2$) V when buffer is OFF.

In the following table, data are guaranteed by design.

Table 52. DAC output on PB4-PB5-PB6⁽¹⁾

Symbol	Parameter	Conditions	Max	Unit
R_{int}	Internal resistance between DAC output and PB4-PB5-PB6 output	$2.7 \text{ V} < V_{DD} < 3.6 \text{ V}$	1.4	k Ω
		$2.4 \text{ V} < V_{DD} < 3.6 \text{ V}$	1.6	
		$2.0 \text{ V} < V_{DD} < 3.6 \text{ V}$	3.2	
		$1.8 \text{ V} < V_{DD} < 3.6 \text{ V}$	8.2	

1. 32 or 28-pin packages only. The DAC channel can be routed either on PB4, PB5 or PB6 using the routing interface I/O switch registers.

Table 53. ADC1 characteristics (continued)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t_S	Sampling time	V_{AIN} PF0/1/2/3 fast channels $V_{DDA} < 2.4$ V	0.43 ⁽³⁾⁽⁴⁾	-	-	μs
		V_{AIN} PF0/1/2/3 fast channels 2.4 V $\leq V_{DDA} \leq 3.6$ V	0.22 ⁽³⁾⁽⁴⁾	-	-	
		V_{AIN} on slow channels $V_{DDA} < 2.4$ V	0.86 ⁽³⁾⁽⁴⁾	-	-	
		V_{AIN} on slow channels 2.4 V $\leq V_{DDA} \leq 3.6$ V	0.41 ⁽³⁾⁽⁴⁾	-	-	
t_{conv}	12-bit conversion time	-	$12 + t_S$			$1/f_{ADC}$
		16 MHz	$1^{(3)}$			μs
t_{WKUP}	Wakeup time from OFF state	-	-	-	3	μs
$t_{IDLE}^{(5)}$	Time before a new conversion	-	-	-	∞	s
$t_{VREFINT}$	Internal reference voltage startup time	-	-	-	refer to Table 46	ms

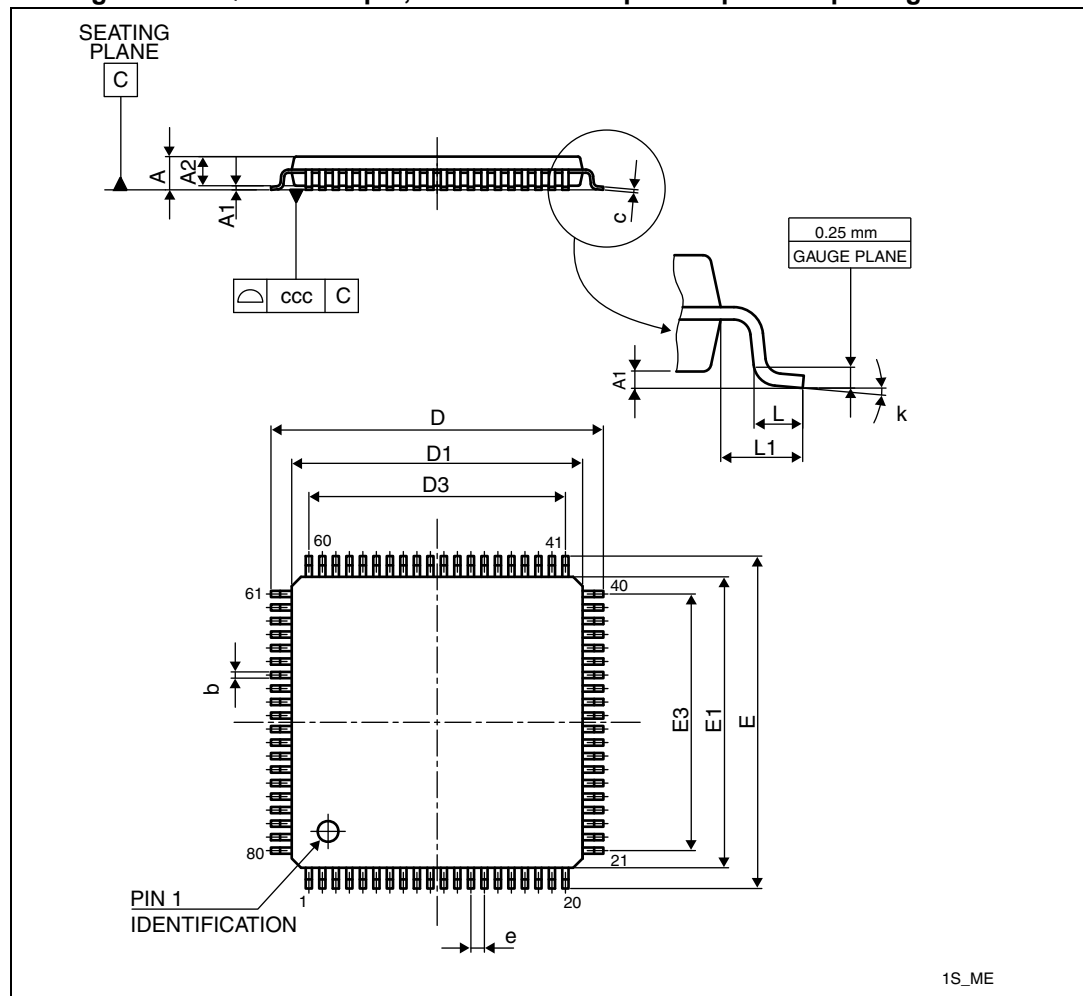
- The current consumption through V_{REF} is composed of two parameters:
 - one constant (max 300 μA)
 - one variable (max 400 μA), only during sampling time + 2 first conversion pulses.
 So, peak consumption is $300+400 = 700$ μA and average consumption is $300 + [(4 \text{ sampling} + 2) / 16] \times 400 = 450$ μA at 1MSPS
- V_{REF-} must be tied to ground.
- Minimum sampling and conversion time is reached for maximum $R_{AIN} = 0.5$ k Ω .
- Value obtained for continuous conversion on fast channel.
- The time between 2 conversions, or between ADC ON and the first conversion must be lower than t_{IDLE} .

10 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

10.1 LQFP80 package information

Figure 48. LQFP80 - 80-pin, 14 x 14 mm low-profile quad flat package outline



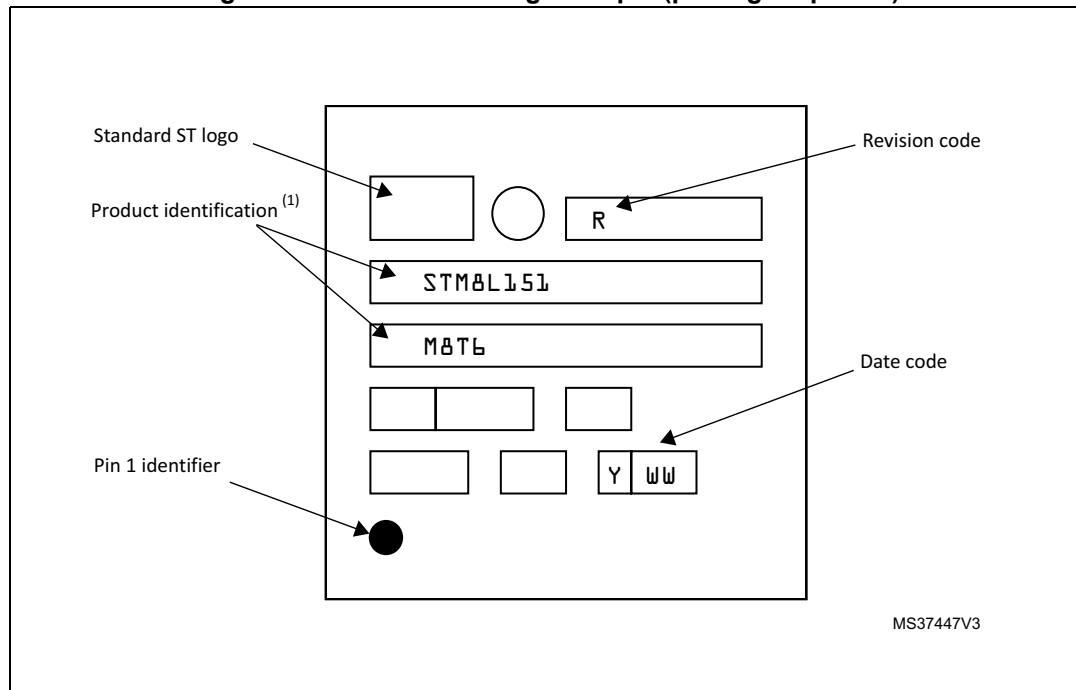
1. Drawing is not to scale.

Device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

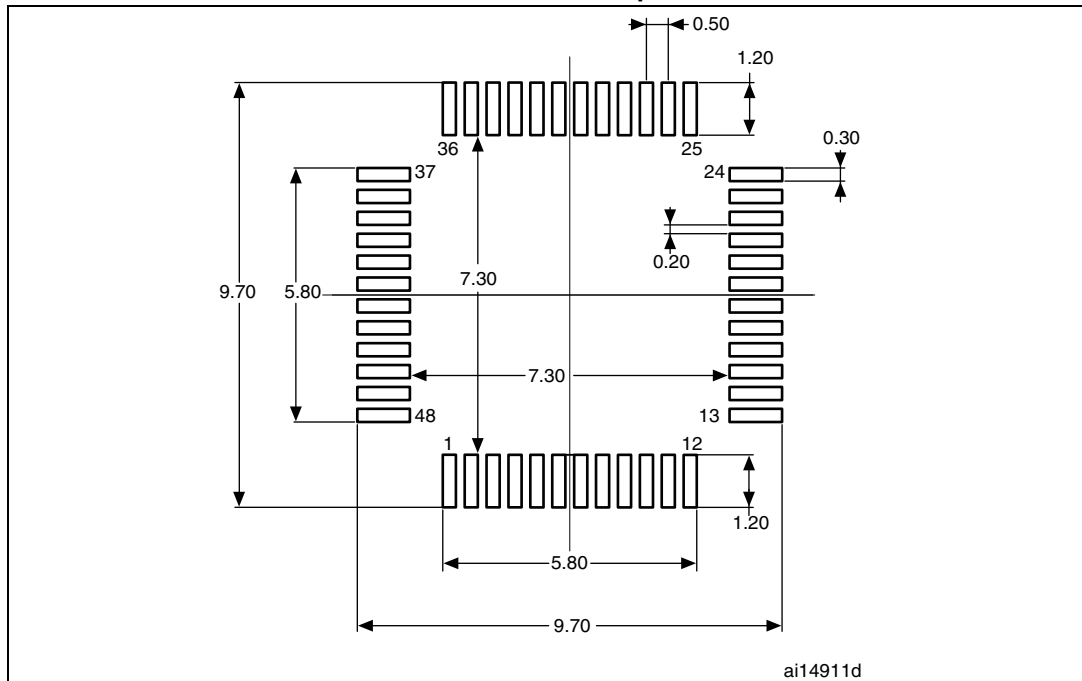
Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

Figure 50. LQFP80 marking example (package top view)



1. Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not yet ready to be used in production and any consequences deriving from such usage will not be at ST charge. In no event, ST will be liable for any customer usage of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering samples to run qualification activity.

**Figure 55. LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package
recommended footprint**



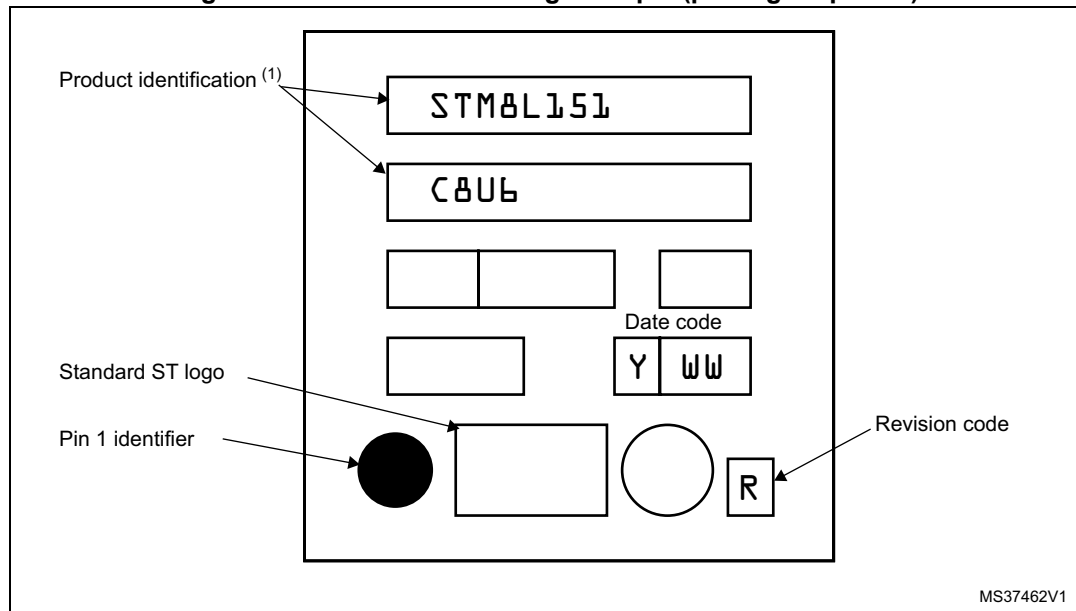
1. Dimensions are expressed in millimeters.

Device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

Figure 59. UFQFPN48 marking example (package top view)



1. Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not yet ready to be used in production and any consequences deriving from such usage will not be at ST charge. In no event, ST will be liable for any customer usage of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering samples to run qualification activity.

Table 70. Document revision history (continued)

Date	Revision	Changes
19-Feb-2015	7	Updated – Table 63: LQFP80 - 80-pin, 14 x 14 mm low-profile quad flat package mechanical data, – Figure 48: LQFP80 - 80-pin, 14 x 14 mm low-profile quad flat package outline, – Figure 49: LQFP80 - 80-pin, 14 x 14 mm low-profile quad flat package recommended footprint, – Table 64: LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package mechanical data, – Figure 51: LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package outline, – Figure 52: LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package recommended footprint, – Table 65: LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package mechanical data, – Figure 54: LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package outline, – Table 66: UFQFPN48 - 48-lead, 7x7 mm, 0.5 mm pitch, ultra thin fine pitch quad flat package mechanical data, – Figure 57: UFQFPN48 - 48-lead, 7x7 mm, 0.5 mm pitch, ultra thin fine pitch quad flat package outline, – Figure 58: UFQFPN48 - 48-lead, 7x7 mm, 0.5 mm pitch, ultra thin fine pitch quad flat package recommended footprint. Added: – Figure 50: LQFP80 marking example (package top view) – Figure 53: LQFP64 marking example (package top view) – Figure 56: LQFP48 marking example (package top view) – Figure 59: UFQFPN48 marking example (package top view)
07-Sep-2015	8	Added – Figure 9: STM8L152K8 32-ball ballout and the related warning, – Section 10.5: WLCSP32 package information. Updated: – Table 1: Device summary, – Table 2: High-density and medium+ density STM8L15xx6/8 low power device features and peripheral counts, – Table 5: High-density and medium+ density STM8L15x pin description, – Table 18: General operating conditions, – Table 60: ESD absolute maximum ratings, – Table 62: Thermal characteristics, – Table 69: Ordering information scheme.
08-Dec-2016	9	Updated TIM3 channel 3 to TIM3 channel 1 (LQFP80 pin 77) and SPI2 clock to SPI1 clock (LQFP80 pin 51) in Table 5: High-density and medium+ density STM8L15x pin description. Updated BOR_TH reference (OPT5) in Table 13: Option byte description.